```	~			
 Application/Control No.		Applicant(s)/Patent Under Reexamination		
10/051,389	SONNTAG E			
Examiner	Art Unit		•	
Dah-Wei D. Yuan	1745	Page 1 of 1		

## Dah-Wei D. Yuan

Notice of References Cited

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,582,840	06-2003	Hortop, Matthew K.	429/13
	В	US-			
	С	US-			-
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
Ţ.	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s			- 1		
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	·
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.